

PATENT ABSTRACTS OF JAPAN

(11)Publication number : 11-118889

(43)Date of publication of application : 30.04.1999

(51)Int.Cl.
G01R 31/3183
G01R 31/28
G06F 11/22
G06F 17/50

(21)Application number : 09-288155

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(22)Date of filing : 21.10.1997

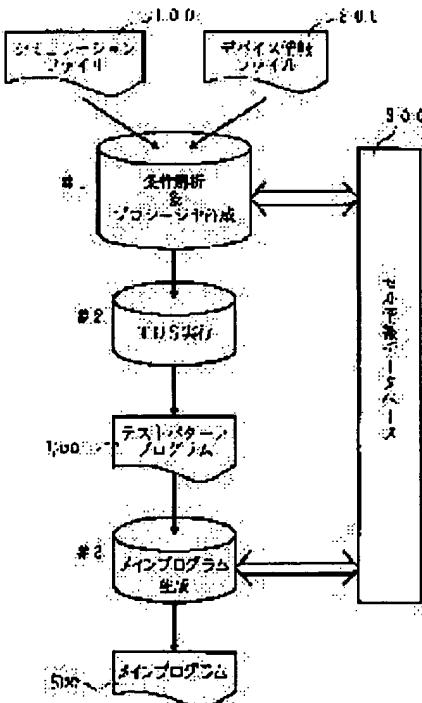
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(54) TEST PROGRAM GENERATING SYSTEM

(57)Abstract:

PROBLEM TO BE SOLVED: To provide a test program generating system which achieves a reduction in the time required to generate a test program, the enhancement of circuit verification accuracy by the generated test program, and uniformity in the degree of perfection of the test program.

SOLUTION: Information stored in a simulation file 100, a device information file 200, and a cell information database 300 is processed by software to generate the procedure necessary for executing the existing software for generating a test pattern program. The existing software is executed by the generated procedure to generate a test pattern program 400. Then the generated test pattern program 400 and the information stored in the device information file 200 and the cell information database 300 are processed by the software to generate a main program 500.



LEGAL STATUS

[Date of request for examination] 20.08.2002

[Date of sending the examiner's decision of rejection]

[Kind of final disposal of application other than the examiner's decision of rejection or application]

[converted registration]

[Date of final disposal for application]

[Patent number]

[Date of registration]

[Number of appeal against examiner's decision of rejection]

[Date of requesting appeal against examiner's decision of rejection]

[Date of extinction of right]

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